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### **Embedded - System On Chip (SoC): The Heart of Modern Embedded Systems**

**Embedded - System On Chip (SoC)** refers to an integrated circuit that consolidates all the essential components of a computer system into a single chip. This includes a microprocessor, memory, and other peripherals, all packed into one compact and efficient package. SoCs are designed to provide a complete computing solution, optimizing both space and power consumption, making them ideal for a wide range of embedded applications.

### **What are Embedded - System On Chip (SoC)?**

**System On Chip (SoC)** integrates multiple functions of a computer or electronic system onto a single chip. Unlike traditional multi-chip solutions, SoCs combine a central

#### **Details**

Product Status	Active
Architecture	MCU, FPGA
Core Processor	ARM® Cortex®-M3
Flash Size	256KB
RAM Size	64KB
Peripherals	DDR, PCIe, SERDES
Connectivity	CANbus, Ethernet, I <sup>2</sup> C, SPI, UART/USART, USB
Speed	166MHz
Primary Attributes	FPGA - 25K Logic Modules
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	325-TFBGA, FCBGA
Supplier Device Package	325-FCBGA (11x11)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/microchip-technology/m2s025-1fcsg325i">https://www.e-xfl.com/product-detail/microchip-technology/m2s025-1fcsg325i</a>

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## 2.3.2 Power Consumption

The following sections describe the power consumptions of the devices.

### 2.3.2.1 Quiescent Supply Current

**Table 10 • Quiescent Supply Current Characteristics**

Power Supplies/Blocks	Modes and Configurations	
	Non-Flash*Freeze	Flash*Freeze
FPGA Core	On	Off
V <sub>DD</sub> /SERDES_[01]_VDD <sup>1</sup>	On	On
V <sub>PP</sub> /V <sub>PPNVM</sub>	On	On
HPMS_MDDR_PLL_VDDA/FDDR_PLL_VDDA/ CCC_XX[01]_PLL_VDDA/PLL0_PLL1_HPMS_MDDR_VDD A	0 V	0 V
SERDES_[01]_PLL_VDDA <sup>2</sup>	0 V	0 V
SERDES_[01]_L[0123]_VDDAPLL/VDD_2V5 <sup>2</sup>	On	On
SERDES_[01]_L[0123]_VDDAIIO <sup>2</sup>	On	On
V <sub>DDIx</sub> <sup>3, 4</sup>	On	On
V <sub>REFx</sub>	On	On
MSSDDR CLK	32 kHz	32 kHz
RAM	On	Sleep state
System controller	50 MHz	50 MHz
50 MHz oscillator (enable/disable)	Enable	Disabled
1 MHz oscillator (enable/disable)	Disabled	Disabled
Crystal oscillator (enable/disable)	Disabled	Disabled

1. SERDES\_[01]\_VDD Power Supply is shorted to V<sub>DD</sub>.
2. SerDes and DDR blocks to be unused.
3. V<sub>DDIx</sub> has been set to ON for test conditions as described. Banks on the east side should always be powered with the appropriate V<sub>DDI</sub> bank supplies. For details on bank power supplies, see "Recommendation for Unused Bank Supplies" table in the *AC393: SmartFusion2 and IGLOO2 Board Design Guidelines Application Note*.
4. No Differential (that is to say, LVDS) I/Os or ODT attributes to be used.

**Table 11 • SmartFusion2 and IGLOO2 Quiescent Supply Current (V<sub>DD</sub> = 1.2 V) – Typical Process**

Symbol	Modes	005	010	025	050	060	090	150	Unit	Conditions
IDC1	Non-Flash*Freeze	6.2	6.9	8.9	13.1	15.3	15.4	27.5	mA	Typical (T <sub>J</sub> = 25 °C)
		24.0	28.4	40.6	67.8	80.6	81.4	144.7	mA	Commercial (T <sub>J</sub> = 85 °C)
		35.2	41.9	60.5	102.1	121.4	122.6	219.1	mA	Industrial (T <sub>J</sub> = 100 °C)

**Table 43 • LVCMOS 2.5 V AC Test Parameter Specifications**

Parameter	Symbol	Typ	Unit
Measuring/trip point for data path	$V_{TRIP}$	1.2	V
Resistance for enable path ( $T_{ZH}$ , $T_{ZL}$ , $T_{HZ}$ , $T_{LZ}$ )	$R_{ENT}$	2K	$\Omega\sigma$
Capacitive loading for enable path ( $T_{ZH}$ , $T_{ZL}$ , $T_{HZ}$ , $T_{LZ}$ )	$C_{ENT}$	5	pF
Capacitive loading for data path ( $T_{DP}$ )	$C_{LOAD}$	5	pF

**Table 44 • LVCMOS 2.5 V Transmitter Drive Strength Specifications**

Output Drive Selection			VOH (V)	VOL (V)	IOH (at VOH) mA	IOL (at VOL) mA
MSIO I/O Bank	MSIOD I/O Bank	DDRIO I/O Bank (With Software Default Fixed Code)	Min	Max		
2 mA	2 mA	2 mA	$V_{DDI} - 0.4$	0.4	2	2
4 mA	4 mA	4 mA	$V_{DDI} - 0.4$	0.4	4	4
6 mA	6 mA	6 mA	$V_{DDI} - 0.4$	0.4	6	6
8 mA	8 mA	8 mA	$V_{DDI} - 0.4$	0.4	8	8
12 mA	12 mA	12 mA	$V_{DDI} - 0.4$	0.4	12	12
16 mA		16 mA	$V_{DDI} - 0.4$	0.4	16	16

**Note:** For board design considerations, output slew rates extraction, detailed output buffer resistances, and I/V Curve, use the corresponding IBIS models located at:  
[www.microsemi.com/soc/download/ibis/default.aspx](http://www.microsemi.com/soc/download/ibis/default.aspx).

**AC Switching Characteristics**

Worst commercial-case conditions:  $T_J = 85\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ ,  $V_{DDI} = 2.375\text{ V}$

**Table 45 • LVCMOS 2.5 V Receiver Characteristics (Input Buffers)**

	On-Die Termination (ODT)	$T_{PY}$		$T_{PYS}$		Unit
		-1	-Std	-1	-Std	
LVCMOS 2.5 V (for DDRIO I/O bank)	None	1.823	2.145	1.932	2.274	ns
LVCMOS 2.5 V (for MSIO I/O bank)	None	2.486	2.925	2.495	2.935	ns
LVCMOS 2.5 V (for MSIOD I/O bank)	None	2.29	2.694	2.305	2.712	ns

**Table 46 • LVCMOS 2.5 V Transmitter Characteristics for DDRIO Bank (Output and Tristate Buffers)**

Output Drive Selection	Slew Control	$T_{DP}$		$T_{ZL}$		$T_{ZH}$		$T_{HZ}^1$		$T_{LZ}^1$		Unit
		-1	-Std	-1	-Std	-1	-Std	-1	-Std	-1	-Std	
2 mA	Slow	3.657	4.302	3.393	3.991	3.675	4.323	3.894	4.582	3.552	4.18	ns
	Medium	3.374	3.97	3.139	3.693	3.396	3.995	3.635	4.277	3.253	3.828	ns
	Medium fast	3.239	3.811	3.036	3.572	3.261	3.836	3.519	4.141	3.128	3.681	ns
	Fast	3.224	3.793	3.029	3.563	3.246	3.818	3.512	4.132	3.119	3.67	ns

**Table 48 • LVCMOS 2.5 V Transmitter Characteristics for MSIOD Bank (Output and Tristate Buffers)**

Output Drive Selection	Slew Control	$T_{DP}$		$T_{ZL}$		$T_{ZH}$		$T_{HZ}^1$		$T_{LZ}^1$		Unit
		-1	-Std	-1	-Std	-1	-Std	-1	-Std	-1	-Std	
2 mA	Slow	2.206	2.596	2.678	3.15	2.64	3.106	4.935	5.805	4.74	5.576	ns
4 mA	Slow	1.835	2.159	2.242	2.637	2.256	2.654	5.413	6.368	5.15	6.059	ns
6 mA	Slow	1.709	2.01	2.132	2.508	2.167	2.549	5.813	6.838	5.499	6.469	ns
8 mA	Slow	1.63	1.918	1.958	2.303	2.012	2.367	6.226	7.324	5.816	6.842	ns
12 mA	Slow	1.648	1.939	1.86	2.187	1.921	2.259	6.519	7.669	6.027	7.09	ns

1. Delay increases with drive strength are inherent to built-in slew control circuitry for simultaneous switching output (SSO) management.

### 2.3.5.8 1.8 V LVCMOS

LVCMOS 1.8 is a general standard for 1.8 V applications and is supported in IGLOO2 FPGAs and SmartFusion2 SoC FPGAs in compliance to the JEDEC specification JESD8-7A.

#### Minimum and Maximum DC/AC Input and Output Levels Specification

**Table 49 • LVCMOS 1.8 V DC Recommended Operating Conditions**

Parameter	Symbol	Min	Typ	Max	Unit
<b>LVCMOS 1.8 V DC Recommended Operating Conditions</b>					
Supply voltage	$V_{DDI}$	1.710	1.8	1.89	V

**Table 50 • LVCMOS 1.8 V DC Input Voltage Specification**

Parameter	Symbol	Min	Max	Unit
DC input logic high (for MSIOD and DDRIO I/O banks)	$V_{IH}$ (DC)	$0.65 \times V_{DDI}$	1.89	V
DC input logic high (for MSIO I/O bank)	$V_{IH}$ (DC)	$0.65 \times V_{DDI}$	3.45	V
DC input logic low	$V_{IL}$ (DC)	-0.3	$0.35 \times V_{DDI}$	V
Input current high <sup>1</sup>	$I_{IH}$ (DC)			-
Input current low <sup>1</sup>	$I_{IL}$ (DC)			-

1. See Table 24, page 22.

**Table 51 • LVCMOS 1.8 V DC Output Voltage Specification**

Parameter	Symbol	Min	Max	Unit
DC output logic high	$V_{OH}$	$V_{DDI} - 0.45$		V
DC output logic low	$V_{OL}$		0.45	V

**Table 52 • LVCMOS 1.8 V Minimum and Maximum AC Switching Speed**

Parameter	Symbol	Max	Unit	Conditions
Maximum data rate (for DDRIO I/O bank) <sup>1</sup>	$D_{MAX}$	400	Mbps	AC loading: 17 pF load, maximum drive/slew
Maximum data rate (for MSIO I/O bank)	$D_{MAX}$	295	Mbps	AC loading: 17 pF load, maximum drive/slew
Maximum data rate (for MSIOD I/O bank) <sup>1</sup>	$D_{MAX}$	400	Mbps	AC loading: 17 pF load, maximum drive/slew

1. Maximum Data Rate applies for Drive Strength 8 mA and above, All Slews.



**Table 57 • LVCMOS 1.8 V Transmitter Characteristics for DDRIO I/O Bank with Fixed Code (Output and Tristate Buffers)**

Output Drive Selection	Slew Control	T <sub>DP</sub>		T <sub>ZL</sub>		T <sub>ZH</sub>		T <sub>HZ</sub> <sup>1</sup>		T <sub>LZ</sub> <sup>1</sup>		Unit
		-1	-Std	-1	-Std	-1	-Std	-1	-Std	-1	-Std	
2 mA	Slow	4.234	4.981	3.646	4.29	4.245	4.995	4.908	5.774	4.434	5.216	ns
	Medium	3.824	4.498	3.282	3.861	3.834	4.511	4.625	5.441	4.116	4.843	ns
	Medium fast	3.627	4.267	3.111	3.66	3.637	4.279	4.481	5.272	3.984	4.687	ns
	Fast	3.605	4.241	3.097	3.644	3.615	4.253	4.472	5.262	3.973	4.674	ns
4 mA	Slow	3.923	4.615	3.314	3.9	3.918	4.61	5.403	6.356	4.894	5.757	ns
	Medium	3.518	4.138	2.961	3.484	3.515	4.135	5.121	6.025	4.561	5.366	ns
	Medium fast	3.321	3.907	2.783	3.275	3.317	3.903	4.966	5.843	4.426	5.206	ns
	Fast	3.301	3.883	2.77	3.259	3.296	3.878	4.957	5.831	4.417	5.196	ns
6 mA	Slow	3.71	4.364	3.104	3.652	3.702	4.355	5.62	6.612	5.08	5.977	ns
	Medium	3.333	3.921	2.779	3.27	3.325	3.913	5.346	6.289	4.777	5.62	ns
	Medium fast	3.155	3.712	2.62	3.083	3.146	3.702	5.21	6.13	4.657	5.479	ns
	Fast	3.134	3.688	2.608	3.068	3.125	3.677	5.202	6.12	4.648	5.468	ns
8 mA	Slow	3.619	4.258	3.007	3.538	3.607	4.244	5.815	6.841	5.249	6.175	ns
	Medium	3.246	3.819	2.686	3.16	3.236	3.807	5.542	6.52	4.936	5.807	ns
	Medium fast	3.066	3.607	2.525	2.971	3.054	3.593	5.405	6.359	4.811	5.66	ns
	Fast	3.046	3.584	2.513	2.957	3.034	3.57	5.401	6.353	4.803	5.651	ns
10 mA	Slow	3.498	4.115	2.878	3.386	3.481	4.096	6.046	7.113	5.444	6.404	ns
	Medium	3.138	3.692	2.569	3.023	3.126	3.678	5.782	6.803	5.129	6.034	ns
	Medium fast	2.966	3.489	2.414	2.841	2.951	3.472	5.666	6.665	5.013	5.897	ns
	Fast	2.945	3.464	2.401	2.826	2.93	3.448	5.659	6.658	5.003	5.886	ns
12 mA	Slow	3.417	4.02	2.807	3.303	3.401	4.002	6.083	7.156	5.464	6.428	ns
	Medium	3.076	3.618	2.519	2.964	3.063	3.604	5.828	6.856	5.176	6.089	ns
	Medium fast	2.913	3.427	2.376	2.795	2.898	3.41	5.725	6.736	5.072	5.966	ns
	Fast	2.894	3.405	2.362	2.78	2.879	3.388	5.715	6.724	5.064	5.957	ns
16 mA	Slow	3.366	3.96	2.751	3.237	3.348	3.939	6.226	7.324	5.576	6.56	ns
	Medium	3.03	3.565	2.47	2.906	3.017	3.55	5.981	7.036	5.282	6.214	ns
	Medium fast	2.87	3.377	2.328	2.739	2.854	3.358	5.895	6.935	5.18	6.094	ns
	Fast	2.853	3.357	2.314	2.723	2.837	3.338	5.889	6.929	5.177	6.09	ns

1. Delay increases with drive strength are inherent to built-in slew control circuitry for simultaneous switching output (SSO) management.



**Table 70 • LVCMOS 1.5 V Transmitter Characteristics for DDRIO I/O Bank (Output and Tristate Buffers)**  
(continued)

Output Drive Selection	Slew Control	T <sub>DP</sub>		T <sub>ZL</sub>		T <sub>ZH</sub>		T <sub>HZ</sub> <sup>1</sup>		T <sub>LZ</sub> <sup>1</sup>		Unit
		-1	-Std	-1	-Std	-1	-Std	-1	-Std	-1	-Std	
6 mA	Slow	4.244	4.993	3.465	4.076	4.233	4.979	6.39	7.518	5.736	6.748	ns
	Medium	3.774	4.44	3.05	3.587	3.762	4.426	6.114	7.193	5.397	6.35	ns
	Medium fast	3.544	4.17	2.839	3.339	3.529	4.152	5.978	7.033	5.27	6.2	ns
	Fast	3.519	4.14	2.82	3.317	3.504	4.122	5.965	7.017	5.259	6.187	ns
8 mA	Slow	4.099	4.823	3.311	3.894	4.087	4.807	6.584	7.746	5.854	6.888	ns
	Medium	3.656	4.301	2.927	3.443	3.642	4.284	6.311	7.425	5.553	6.533	ns
	Medium fast	3.437	4.044	2.731	3.213	3.42	4.023	6.182	7.273	5.435	6.394	ns
	Fast	3.41	4.012	2.715	3.193	3.393	3.991	6.178	7.269	5.425	6.383	ns
10 mA	Slow	4.029	4.74	3.238	3.809	4.015	4.723	6.732	7.921	5.965	7.018	ns
	Medium	3.601	4.237	2.867	3.372	3.586	4.218	6.473	7.615	5.669	6.669	ns
	Medium fast	3.384	3.981	2.672	3.143	3.365	3.958	6.351	7.471	5.55	6.529	ns
	Fast	3.357	3.949	2.655	3.123	3.338	3.927	6.345	7.464	5.54	6.518	ns
12 mA	Slow	3.974	4.675	3.196	3.759	3.958	4.656	6.842	8.049	6.068	7.139	ns
	Medium	3.55	4.176	2.827	3.326	3.534	4.157	6.584	7.746	5.751	6.766	ns
	Medium fast	3.345	3.935	2.638	3.103	3.325	3.911	6.488	7.633	5.641	6.637	ns
	Fast	3.316	3.902	2.621	3.083	3.297	3.878	6.486	7.63	5.626	6.619	ns

1. Delay increases with drive strength are inherent to built-in slew control circuitry for simultaneous switching output (SSO) management.

**Table 71 • LVCMOS 1.5 V Transmitter Characteristics for MSIO I/O Bank (Output and Tristate Buffers)**

Output Drive Selection	Slew Control	T <sub>DP</sub>		T <sub>ZL</sub>		T <sub>ZH</sub>		T <sub>HZ</sub> <sup>1</sup>		T <sub>LZ</sub> <sup>1</sup>		Unit
		-1	-Std	-1	-Std	-1	-Std	-1	-Std	-1	-Std	
2 mA	Slow	4.423	5.203	5.397	6.35	5.686	6.69	5.609	6.599	5.561	6.542	ns
4 mA	Slow	4.05	4.765	4.503	5.298	4.92	5.788	7.358	8.657	6.525	7.677	ns
6 mA	Slow	4.081	4.801	4.259	5.012	4.699	5.528	7.659	9.011	6.709	7.893	ns
8 mA	Slow	4.234	4.98	4.068	4.786	4.521	5.319	8.218	9.668	7.05	8.294	ns

1. Delay increases with drive strength are inherent to built-in slew control circuitry for simultaneous switching output (SSO) management.

**Table 95 • HSTL DC Output Voltage Specification Applicable to DDRIO I/O Bank Only**

Parameter	Symbol	Min	Max	Unit
<b>HSTL Class I</b>				
DC output logic high	$V_{OH}$	$V_{DDI} - 0.4$		V
DC output logic low	$V_{OL}$		0.4	V
Output minimum source DC current (MSIO and DDRIO I/O banks)	$I_{OH}$ at $V_{OH}$	-8.0		mA
Output minimum sink current (MSIO and DDRIO I/O banks)	$I_{OL}$ at $V_{OL}$	8.0		mA
<b>HSTL Class II</b>				
DC output logic high	$V_{OH}$	$V_{DDI} - 0.4$		V
DC output logic low	$V_{OL}$		0.4	V
Output minimum source DC current	$I_{OH}$ at $V_{OH}$	-16.0		mA
Output minimum sink current	$I_{OL}$ at $V_{OL}$	16.0		mA

**Table 96 • HSTL DC Differential Voltage Specification**

Parameter	Symbol	Min	Unit
DC input differential voltage	$V_{ID}$ (DC)	0.2	V

**Table 97 • HSTL AC Differential Voltage Specifications**

Parameter	Symbol	Min	Max	Unit
AC input differential voltage	$V_{DIFF}$	0.4		V
AC differential cross point voltage	$V_x$	0.68	0.9	V

**Table 98 • HSTL Minimum and Maximum AC Switching Speed**

Parameter	Symbol	Max	Unit	Conditions
Maximum data rate	$D_{MAX}$	400	Mbps	AC loading: per JEDEC specifications

**Table 99 • HSTL Impedance Specification**

Parameter	Symbol	Typ	Unit	Conditions
Supported output driver calibrated impedance (for DDRIO I/O bank)	$R_{REF}$	25.5, 47.8	$\Omega$	Reference resistance = 191 $\Omega$
Effective impedance value (ODT for DDRIO I/O bank only)	$R_{TT}$	47.8	$\Omega$	Reference resistance = 191 $\Omega$

### 2.3.6.3 Stub-Series Terminated Logic 2.5 V (SSTL2)

SSTL2 Class I and Class II are supported in IGLOO2 and SmartFusion2 SoC FPGAs and also comply with reduced and full drive of double data rate (DDR) standards. IGLOO2 and SmartFusion2 SoC FPGA I/Os supports both standards for single-ended signaling and differential signaling for SSTL2. This standard requires a differential amplifier input buffer and a push-pull output buffer.

#### Minimum and Maximum DC/AC Input and Output Levels Specification

**Table 103 • DDR1/SSTL2 DC Recommended Operating Conditions**

Parameter	Symbol	Min	Typ	Max	Unit
Supply voltage	$V_{DDI}$	2.375	2.5	2.625	V
Termination voltage	$V_{TT}$	1.164	1.250	1.339	V
Input reference voltage	$V_{REF}$	1.164	1.250	1.339	V

**Table 104 • DDR1/SSTL2 DC Input Voltage Specification**

Parameter	Symbol	Min	Max	Unit
DC input logic high	$V_{IH}$ (DC)	$V_{REF} + 0.15$	2.625	V
DC input logic low	$V_{IL}$ (DC)	-0.3	$V_{REF} - 0.15$	V
Input current high <sup>1</sup>	$I_{IH}$ (DC)			
Input current low <sup>1</sup>	$I_{IL}$ (DC)			

1. See Table 24, page 22.

**Table 105 • DDR1/SSTL2 DC Output Voltage Specification**

Parameter	Symbol	Min	Max	Unit
<b>SSTL2 Class I (DDR Reduced Drive)</b>				
DC output logic high	$V_{OH}$	$V_{TT} + 0.608$		V
DC output logic low	$V_{OL}$		$V_{TT} - 0.608$	V
Output minimum source DC current	$I_{OH}$ at $V_{OH}$	8.1		mA
Output minimum sink current	$I_{OL}$ at $V_{OL}$	-8.1		mA
<b>SSTL2 Class II (DDR Full Drive) – Applicable to MSIO and DDRIO I/O Bank Only</b>				
DC output logic high	$V_{OH}$	$V_{TT} + 0.81$		V
DC output logic low	$V_{OL}$		$V_{TT} - 0.81$	V
Output minimum source DC current	$I_{OH}$ at $V_{OH}$	16.2		mA
Output minimum sink current	$I_{OL}$ at $V_{OL}$	-16.2		mA

**Table 106 • DDR1/SSTL2 DC Differential Voltage Specification**

Parameter	Symbol	Min	Unit
DC input differential voltage	$V_{ID}$ (DC)	0.3	V

**Table 168 • LVDS25 Receiver Characteristics for MSIOD I/O Bank (Input Buffers)**

On-Die Termination (ODT)	$T_{PY}$		Unit
	-1	-Std	
None	2.554	3.004	ns
100	2.549	2.999	ns

**Table 169 • LVDS25 Transmitter Characteristics for MSIO I/O Bank (Output and Tristate Buffers)**

$T_{DP}$		$T_{ZL}$		$T_{ZH}$		$T_{HZ}$		$T_{LZ}$		Unit
-1	-Std	-1	-Std	-1	-Std	-1	-Std	-1	-Std	
2.136	2.513	2.416	2.842	2.402	2.825	2.423	2.85	2.409	2.833	ns

**Table 170 • LVDS25 Transmitter Characteristics for MSIOD I/O Bank (Output and Tristate Buffers)**

	$T_{DP}$		$T_{ZL}$		$T_{ZH}$		$T_{HZ}$		$T_{LZ}$		Unit
	-1	-Std	-1	-Std	-1	-Std	-1	-Std	-1	-Std	
No pre-emphasis	1.61	1.893	1.749	2.058	1.735	2.041	1.897	2.231	1.866	2.195	ns
Min pre-emphasis	1.527	1.796	1.757	2.067	1.744	2.052	1.905	2.241	1.876	2.207	ns
Med pre-emphasis	1.496	1.76	1.765	2.077	1.751	2.06	1.914	2.252	1.884	2.216	ns

**LVDS33 AC Switching Characteristics****Table 171 • LVDS33 Receiver Characteristics for MSIO I/O Bank (Input Buffers)**

On Die Termination (ODT)	$T_{PY}$		Unit
	-1	-Std	
None	2.572	3.025	ns
100	2.569	3.023	ns

**Table 172 • LVDS33 Transmitter Characteristics for MSIO I/O Bank (Output and Tristate Buffers)**

$T_{DP}$		$T_{ZL}$		$T_{ZH}$		$T_{HZ}$		$T_{LZ}$		Unit
-1	-Std	-1	-Std	-1	-Std	-1	-Std	-1	-Std	
1.942	2.284	1.98	2.33	1.97	2.318	1.953	2.298	1.96	2.307	ns

**Table 198 • Mini-LVDS AC Impedance Specifications**

Parameter	Symbol	Typ	Unit
Termination resistance	$R_T$	100	$\Omega$

**Table 199 • Mini-LVDS AC Test Parameter Specifications**

Parameter	Symbol	Typ	Unit
Measuring/trip point for data path	$V_{TRIP}$	Cross point	V
Resistance for enable path ( $T_{ZH}$ , $T_{ZL}$ , $T_{HZ}$ , $T_{LZ}$ )	$R_{ENT}$	2K	$\Omega$
Capacitive loading for enable path ( $T_{ZH}$ , $T_{ZL}$ , $T_{HZ}$ , $T_{LZ}$ )	$C_{ENT}$	5	pF

**AC Switching Characteristics**

Worst commercial-case conditions:  $T_J = 85\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ ,  $V_{DDI} = 2.375\text{ V}$ .

**Table 200 • Mini-LVDS AC Switching Characteristics for Receiver (for MSIO I/O Bank - Input Buffers)**

On-Die Termination (ODT)	$T_{PY}$		Unit
	-1	-Std	
None	2.855	3.359	ns
100	2.85	3.353	ns
None	2.602	3.061	ns
100	2.597	3.055	ns

**Table 201 • Mini-LVDS AC Switching Characteristics for Transmitter for MSIO I/O Bank (Output and Tristate Buffers)**

$T_{DP}$		$T_{ZL}$		$T_{ZH}$		$T_{HZ}$		$T_{LZ}$		Unit
-1	-Std	-1	-Std	-1	-Std	-1	-Std	-1	-Std	
2.097	2.467	2.308	2.715	2.296	2.701	1.964	2.31	1.949	2.293	ns

**Table 202 • Mini-LVDS AC Switching Characteristics for Transmitter (for MSIOD I/O Bank - Output and Tristate Buffers)**

	$T_{DP}$		$T_{ZL}$		$T_{ZH}$		$T_{HZ}$		$T_{LZ}$		Unit
	-1	-Std	-1	-Std	-1	-Std	-1	-Std	-1	-Std	
No pre-emphasis	1.614	1.899	1.562	1.837	1.553	1.826	1.593	1.874	1.578	1.856	ns
Min pre-emphasis	1.604	1.887	1.745	2.053	1.731	2.036	1.892	2.225	1.861	2.189	ns
Med pre-emphasis	1.521	1.79	1.753	2.062	1.737	2.043	1.9	2.235	1.868	2.197	ns
Max pre-emphasis	1.492	1.754	1.762	2.073	1.745	2.052	1.91	2.247	1.876	2.206	ns

### 2.3.7.5 RSDS

Reduced Swing Differential Signaling (RSDS) is similar to an LVDS high-speed interface using differential signaling. RSDS has a similar implementation to LVDS devices and is only intended for point-to-point applications.

#### Minimum and Maximum Input and Output Levels

**Table 203 • RSDS Recommended DC Operating Conditions**

Parameter	Symbol	Min	Typ	Max	Unit
Supply voltage	$V_{DDI}$	2.375	2.5	2.625	V

**Table 204 • RSDS DC Input Voltage Specification**

Parameter	Symbol	Min	Max	Unit
DC input voltage	$V_I$	0	2.925	V

**Table 205 • RSDS DC Output Voltage Specification**

Parameter	Symbol	Min	Typ	Max	Unit
DC output logic high	$V_{OH}$	1.25	1.425	1.6	V
DC output logic low	$V_{OL}$	0.9	1.075	1.25	V

**Table 206 • RSDS Differential Voltage Specification**

Parameter	Symbol	Min	Max	Unit
Differential output voltage swing	$V_{OD}$	100	600	mV
Output common mode voltage	$V_{OCM}$	0.5	1.5	V
Input common mode voltage	$V_{ICM}$	0.3	1.5	V
Input differential voltage	$V_{ID}$	100	600	mV

**Table 207 • RSDS Minimum and Maximum AC Switching Speed**

Parameter	Symbol	Max	Unit	Conditions
Maximum data rate (for MSIO I/O bank)	$D_{MAX}$	520	Mbps	AC loading: 2 pF / 100 $\Omega$ differential load
Maximum data rate (for MSIOD I/O bank)	$D_{MAX}$	700	Mbps	AC loading: 2 pF / 100 $\Omega$ differential load

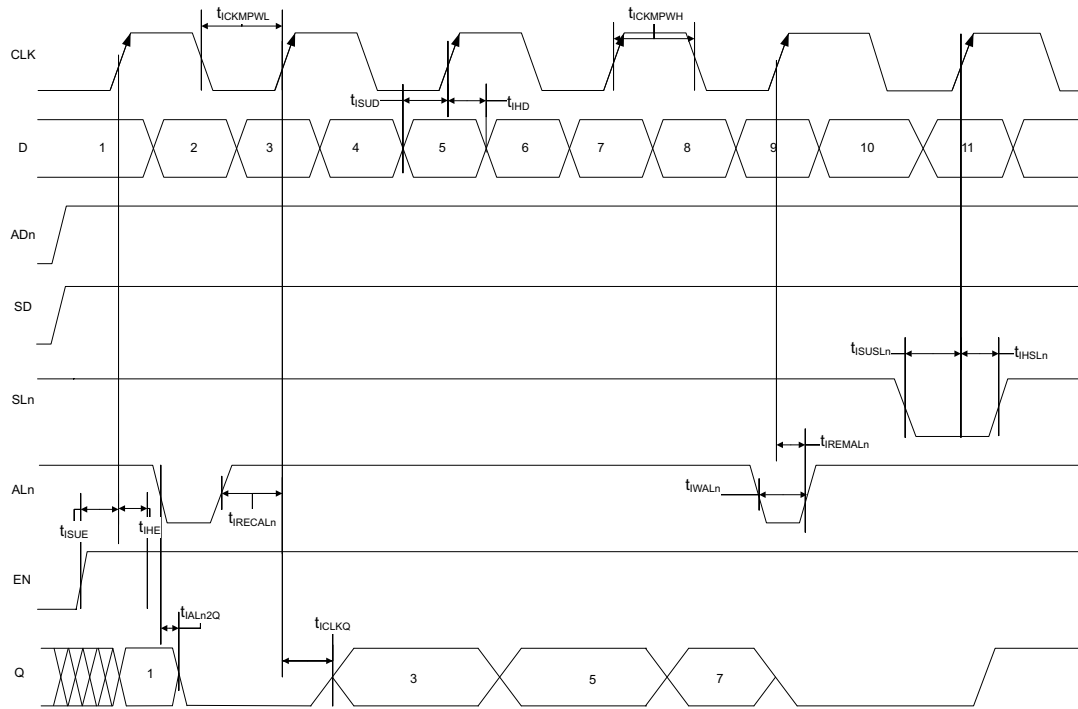
**Table 208 • RSDS AC Impedance Specifications**

Parameter	Symbol	Typ	Unit
Termination resistance	RT	100	$\Omega$

**Table 209 • RSDS AC Test Parameter Specifications**

Parameter	Symbol	Typ	Unit
Measuring/trip point for data path	$V_{TRIP}$	Cross point	V
Resistance for enable path ( $T_{ZH}$ , $T_{ZL}$ , $T_{HZ}$ , $T_{LZ}$ )	$R_{ENT}$	2K	$\Omega$
Capacitive loading for enable path ( $T_{ZH}$ , $T_{ZL}$ , $T_{HZ}$ , $T_{LZ}$ )	$C_{ENT}$	5	pF

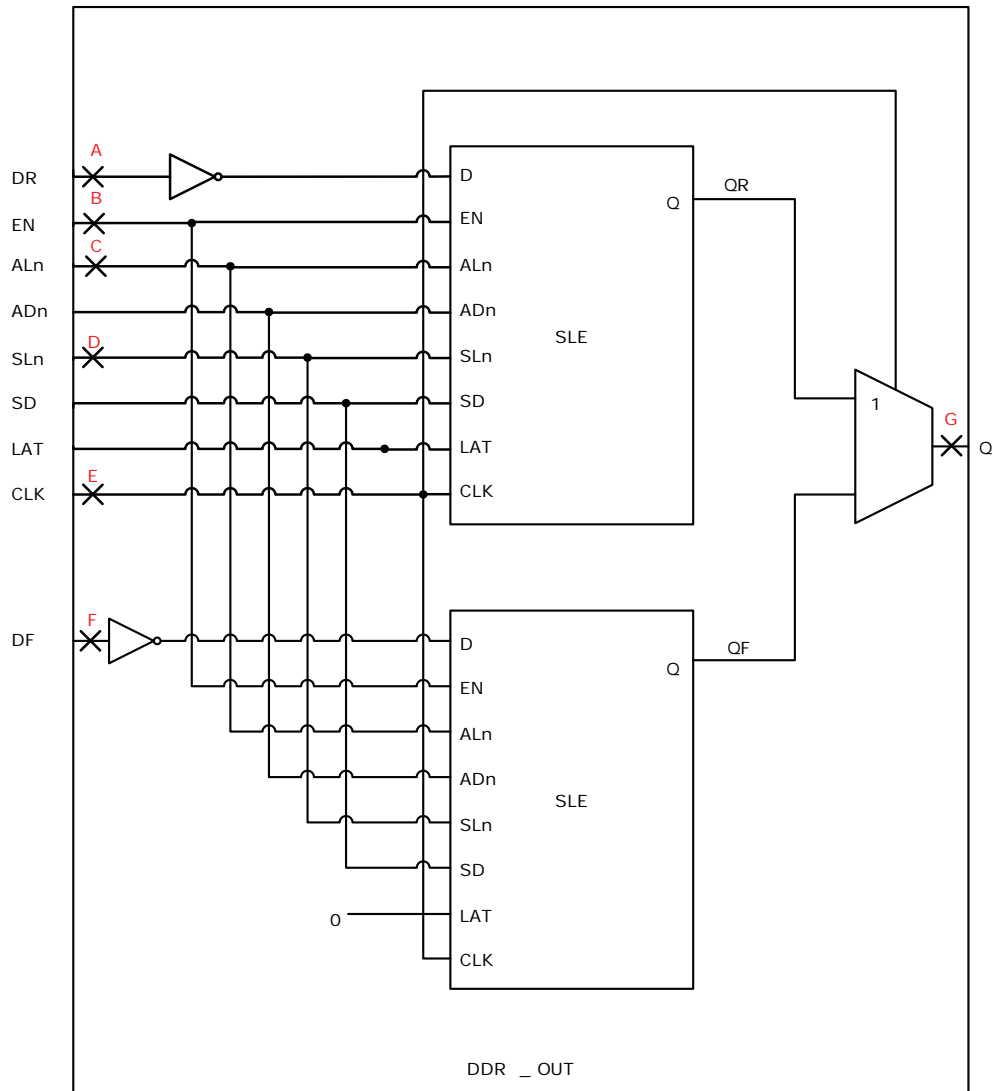
**Figure 7 • I/O Register Input Timing Diagram**





**2.3.9.4 Output DDR Module**

**Figure 12 • Output DDR Module**



## 2.3.11 Global Resource Characteristics

The IGLOO2 and SmartFusion2 SoC FPGA devices offer a powerful, low skew global routing network which provides an effective clock distribution throughout the FPGA fabric. See [UG0445: IGLOO2 FPGA and SmartFusion2 SoC FPGA Fabric User Guide](#) for the positions of various global routing resources.

The following table lists the 150 device global resources in worst commercial-case conditions when  $T_J = 85\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 225 • 150 Device Global Resource**

Parameter	Symbol	-1		-Std		Unit
		Min	Max	Min	Max	
Input low delay for global clock	$T_{RCKL}$	0.83	0.911	0.831	0.913	ns
Input high delay for global clock	$T_{RCKH}$	1.457	1.588	1.715	1.869	ns
Maximum skew for global clock	$T_{RCKSW}$		0.131		0.154	ns

The following table lists the 090 device global resources in worst commercial-case conditions when  $T_J = 85\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 226 • 090 Device Global Resource**

Parameter	Symbol	-1		-Std		Unit
		Min	Max	Min	Max	
Input low delay for global clock	$T_{RCKL}$	0.835	0.888	0.833	0.886	ns
Input high delay for global clock	$T_{RCKH}$	1.405	1.489	1.654	1.752	ns
Maximum skew for global clock	$T_{RCKSW}$		0.084		0.098	ns

The following table lists the 050 device global resources in worst commercial-case conditions when  $T_J = 85\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 227 • 050 Device Global Resource**

Parameter	Symbol	-1		-Std		Unit
		Min	Max	Min	Max	
Input low delay for global clock	$T_{RCKL}$	0.827	0.897	0.826	0.896	ns
Input high delay for global clock	$T_{RCKH}$	1.419	1.53	1.671	1.8	ns
Maximum skew for global clock	$T_{RCKSW}$		0.111		0.129	ns

The following table lists the 025 device global resources in worst commercial-case conditions when  $T_J = 85\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 228 • 025 Device Global Resource**

Parameter	Symbol	-1		-Std		Unit
		Min	Max	Min	Max	
Input low delay for global clock	$T_{RCKL}$	0.747	0.799	0.745	0.797	ns
Input high delay for global clock	$T_{RCKH}$	1.294	1.378	1.522	1.621	ns
Maximum skew for global clock	$T_{RCKSW}$		0.084		0.099	ns

**Table 237 •  $\mu$ SRAM (RAM64x18) in 64 × 18 Mode (continued)**

Parameter	Symbol	-1		-Std		Unit
		Min	Max	Min	Max	
Write address setup time	$T_{ADDRCSU}$	0.088		0.104		ns
Write address hold time	$T_{ADDRCHD}$	0.128		0.15		ns
Write enable setup time	$T_{WECSU}$	0.397		0.467		ns
Write enable hold time	$T_{WECHD}$	-0.026		-0.03		ns
Maximum frequency	$F_{MAX}$		250		250	MHz

The following table lists the  $\mu$ SRAM in 64 × 16 mode in worst commercial-case conditions when  $T_J = 85\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

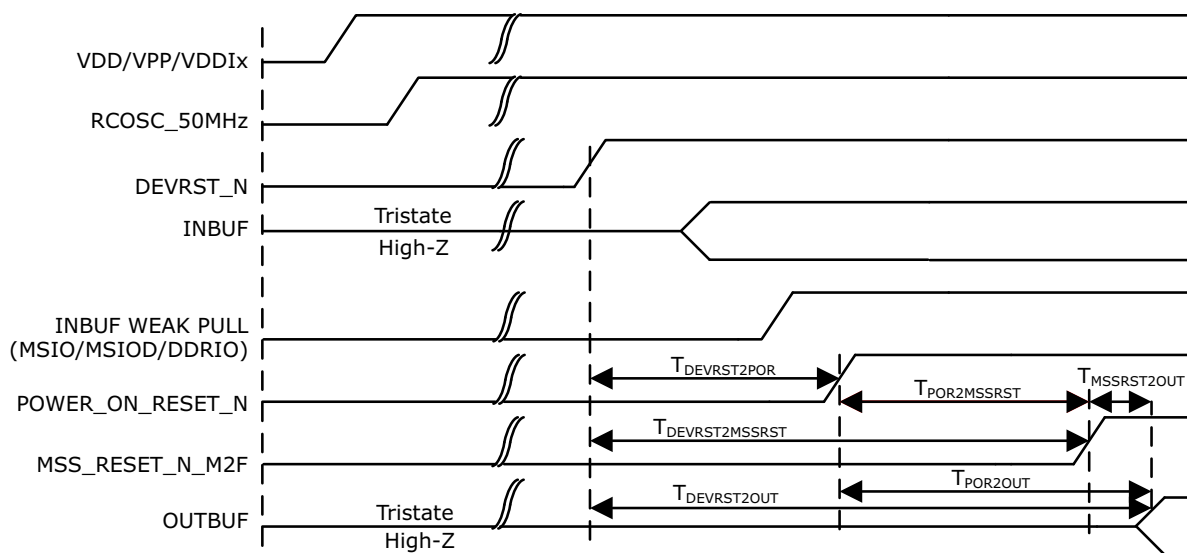
**Table 238 •  $\mu$ SRAM (RAM64x16) in 64 × 16 Mode**

Parameter	Symbol	-1		-Std		Unit
		Min	Max	Min	Max	
Read clock period	$T_{CY}$	4		4		ns
Read clock minimum pulse width high	$T_{CLKMPWH}$	1.8		1.8		ns
Read clock minimum pulse width low	$T_{CLKMPWL}$	1.8		1.8		ns
Read pipeline clock period	$T_{PLCY}$	4		4		ns
Read pipeline clock minimum pulse width high	$T_{PLCLKMPWH}$	1.8		1.8		ns
Read pipeline clock minimum pulse width low	$T_{PLCLKMPWL}$	1.8		1.8		ns
Read access time with pipeline register	$T_{CLK2Q}$		0.266		0.313	ns
Read access time without pipeline register				1.677		1.973
Read address setup time in synchronous mode	$T_{ADDRSU}$	0.301		0.354		ns
Read address setup time in asynchronous mode			1.856		2.184	
Read address hold time in synchronous mode	$T_{ADDRHD}$	0.091		0.107		ns
Read address hold time in asynchronous mode			-0.778		-0.915	
Read enable setup time	$T_{RDENSU}$	0.278		0.327		ns
Read enable hold time	$T_{RDENHD}$	0.057		0.067		ns
Read block select setup time	$T_{BLKSU}$	1.839		2.163		ns
Read block select hold time	$T_{BLKHD}$	-0.65		-0.765		ns
Read block select to out disable time (when pipelined register is disabled)	$T_{BLK2Q}$		2.036		2.396	ns
Read asynchronous reset removal time (pipelined clock)	$T_{RSTREM}$	-0.023		-0.027		ns
Read asynchronous reset removal time (non-pipelined clock)			0.046		0.054	
Read asynchronous reset recovery time (pipelined clock)	$T_{RSTREC}$	0.507		0.597		ns
Read asynchronous reset recovery time (non-pipelined clock)			0.236		0.278	
Read asynchronous reset to output propagation delay (with pipelined register enabled)	$T_{R2Q}$		0.835		0.983	ns
Read synchronous reset setup time	$T_{SRSTSU}$	0.271		0.319		ns

**Table 291 • DEVRST\_N to Functional Times for SmartFusion2 (continued)**

Symbol	From	To	Description	Maximum Power-up to Functional Time for SmartFusion2 (uS)						
				005	010	025	050	060	090	150
$T_{DEVRST2POR}$	DEVRST_N	POWER_ON_RESET_N	$V_{DD}$ at its minimum threshold level to fabric	233	289	216	213	237	234	219
$T_{DEVRST2MSSRST}$	DEVRST_N	MSS_RESET_N_M2F	$V_{DD}$ at its minimum threshold level to MSS	702	765	712	688	636	630	866
$T_{DEVRST2WPU}$	DEVRST_N	DDRIO Inbuf weak pull	DEVRST_N to Inbuf weak pull	208	202	197	193	216	215	215
	DEVRST_N	MSIO Inbuf weak pull	DEVRST_N to Inbuf weak pull	208	202	197	193	216	215	215
	DEVRST_N	MSIOD Inbuf weak pull	DEVRST_N to Inbuf weak pull	208	202	197	193	216	215	215

**Figure 19 • DEVRST\_N to Functional Timing Diagram for SmartFusion2**



The following table lists the SerDes reference clock AC specifications in worst-case industrial conditions when  $T_J = 100\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 299 • SerDes Reference Clock AC Specifications**

Parameter	Symbol	Min	Max	Unit
Reference clock frequency	$F_{REFCLK}$	100	160	MHz
Reference clock rise time	$T_{RISE}$	0.6	4	V/ns
Reference clock fall time	$T_{FALL}$	0.6	4	V/ns
Reference clock duty cycle	$T_{CYC}$	40	60	%
Reference clock mismatch	$M_{MREFCLK}$	-300	300	ppm
Reference spread spectrum clock	$SSC_{ref}$	0	5000	ppm

**Table 300 • HCSL Minimum and Maximum DC Input Levels (Applicable to SerDes REFCLK Only)**

Parameter	Symbol	Min	Typ	Max	Unit
<b>Recommended DC Operating Conditions</b>					
Supply voltage	$V_{DDI}$	2.375	2.5	2.625	V
<b>HCSL DC Input Voltage Specification</b>					
DC Input voltage	$V_I$	0		2.625	V
<b>HCSL Differential Voltage Specification</b>					
Input common mode voltage	$V_{ICM}$	0.05		2.4	V
Input differential voltage	$V_{IDIFF}$	100		1100	mV

**Table 301 • HCSL Minimum and Maximum AC Switching Speeds (Applicable to SerDes REFCLK Only)**

Parameter	Symbol	Min	Typ	Max	Unit
<b>HCSL AC Specifications</b>					
Maximum data rate (for MSIO I/O bank)	$F_{MAX}$			350	Mbps
<b>HCSL Impedance Specifications</b>					
Termination resistance	$R_t$		100		$\Omega$

## 2.3.31 SmartFusion2 Specifications

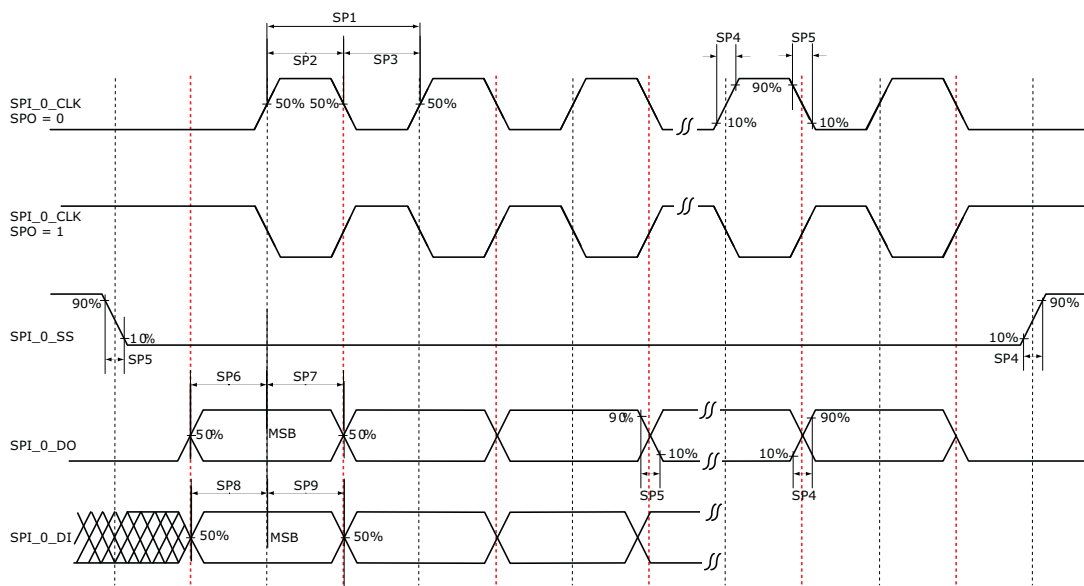
### 2.3.31.1 MSS Clock Frequency

The following table lists the maximum frequency for MSS main clock in worst-case industrial conditions when  $T_J = 100\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

**Table 302 • Maximum Frequency for MSS Main Clock**

Symbol	Description	-1	-Std	Unit
M3_CLK	Maximum frequency for the MSS main clock	166	142	MHz

Figure 22 • SPI Timing for a Single Frame Transfer in Motorola Mode (SPH = 1)



### 2.3.32 CAN Controller Characteristics

The following table lists the CAN controller characteristics in worst-case industrial conditions when  $T_J = 100\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

Table 306 • CAN Controller Characteristics

Parameter	Description	-1	-Std	Unit
FCANREFCLK <sup>1</sup>	Internally sourced CAN reference clock frequency	160	136	MHz
BAUDCANMAX	Maximum CAN performance baud rate	1	1	Mbps
BAUDCANMIN	Minimum CAN performance baud rate	0.05	0.05	Mbps

1. PCLK to CAN controller must be a multiple of 8 MHz.

### 2.3.33 USB Characteristics

The following table lists the USB characteristics in worst-case industrial conditions when  $T_J = 100\text{ }^\circ\text{C}$ ,  $V_{DD} = 1.14\text{ V}$ .

Table 307 • USB Characteristics

Parameter	Description	-1	-Std	Unit
FUSBREFCLK	Internally sourced USB reference clock frequency	166	142	MHz
TUSBCLK	USB clock period	16.66	16.66	ns
TUSBPD	Clock to USB data propagation delay	9.0	9.0	ns
TUSBSU	Setup time for USB data	6.0	6.0	ns
TUSBHD	Hold time for USB data	0	0	ns